TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74HC107AP,TC74HC107AF,TC74HC107AFN

Dual J-K Flip Flop with Clear

The TC74HC107A is a high speed CMOS DUAL J-K FLIP FLOP fabricated with silicon gate C^2MOS technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

In accordance with the logic levels applied to the J and K inputs, the outputs change state on the negative going transition of the clock pulse.

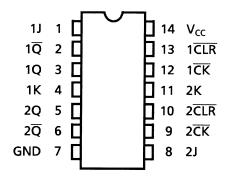
 $\overline{\text{CLR}}$ is independent of the clock and is accomplished by a low logic level on the input.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

Features

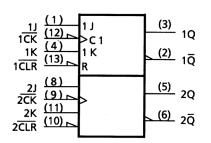
- High speed: $f_{max} = 75 \text{ MHz}$ (typ.) at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $I_{CC} = 2 \ \mu A \ (max)$ at $Ta = 25^{\circ}C$
- High noise immunity: $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (min)
- Output drive capability: 10 LSTTL loads
- Symmetrical output impedance: |IOH| = IOL = 4 mA (min)
- Balanced propagation delays: $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range: V_{CC} (opr) = 2~6 V
- Pin and function compatible with 74LS107

Pin Assignment

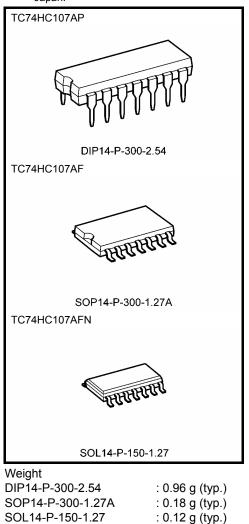




IEC Logic Symbol



Note: xxxFN (JEDEC SOP) is not available in Japan.



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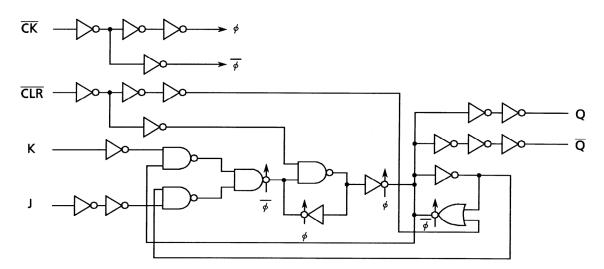
<u>TOSHIBA</u>

Truth Table

	Inputs				puts	Function	
CLR	J	К	СК	Q	IQ	Function	
L	Х	Х	Х	L	Н	Clear	
Н	L	L		Qn	\overline{Q}_{n}	No Change	
Н	L	Н		L	Н	—	
Н	Н	L		Н	L	—	
Н	Н	Н		\overline{Q}_{n}	Qn	Toggle	
Н	Х	Х		Qn	\overline{Q}_{n}	No Change	

X: Don't care

System Diagram



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	-0.5~7	V
DC input voltage	VIN	$-0.5 \sim V_{CC} + 0.5$	V
DC output voltage	V _{OUT}	$-0.5 \sim V_{CC} + 0.5$	V
Input diode current	IIК	±20	mA
Output diode current	IOK	±20	mA
DC output current	IOUT	±25	mA
DC V _{CC} /ground current	ICC	±50	mA
Power dissipation	PD	500 (DIP) (Note 2)/180 (SOP)	mW
Storage temperature	T _{stg}	-65~150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: 500 mW in the range of $Ta = -40^{\circ}C \sim 65^{\circ}C$. From $Ta = 65^{\circ}C$ to $85^{\circ}C$ a derating factor of $-10 \text{ mW/}^{\circ}C$ shall be applied until 300 mW.

Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	e V _{CC} 2~6		V
Input voltage	V _{IN}	0~V _{CC}	V
Output voltage	V _{OUT}	0~V _{CC}	V
Operating temperature	T _{opr}	-40~85	°C
		0~1000 (V _{CC} = 2.0 V)	
Input rise and fall time	t _r , t _f	0~500 (V _{CC} = 4.5 V)	ns
		0~400 (V _{CC} = 6.0 V)	

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Electrical Characteristics

DC Characteristics

		Test Condition			-	Ta = 25°C		Ta = -40~85°C		
Characteristics Symbol				V _{CC} (V)	Min	Тур.	Max	Min	Max	Unit
				2.0	1.50			1.50		
High-level input voltage	VIH		—	4.5	3.15			3.15	—	V
Ũ					4.20		_	4.20	—	
				2.0			0.50		0.50	
Low-level input voltage	VIL	_		4.5			1.35		1.35	V
Ŭ				6.0			1.80		1.80	
	Vон	V _{IN} = V _{IH} or V _{IL}		2.0	1.9	2.0		1.9	—	
			$I_{OH} = -20 \ \mu A$	4.5	4.4	4.5		4.4	—	
High-level output voltage				6.0	5.9	6.0	—	5.9	—	V
, , , , , , , , , , , , , , , , , , ,			$I_{OH} = -4 \text{ mA}$	4.5	4.18	4.31	—	4.13	—	
			I _{OH} = -5.2 mA	6.0	5.68	5.80	—	5.63	—	
	V _{OL}	VIN		2.0	_	0.0	0.1	_	0.1	
			$I_{OL} = 20 \ \mu A$	4.5		0.0	0.1		0.1	
Low-level output voltage		= V _{IH} or		6.0		0.0	0.1		0.1	V
Ũ		VIL	$I_{OL} = 4 \text{ mA}$	4.5	_	0.17	0.26	_	0.33	
			I _{OL} = 5.2 mA	6.0		0.18	0.26		0.33	
Input leakage current	I _{IN}	V _{IN} = V _{CC} or GND		6.0			±0.1	_	±1.0	μA
Quiescent supply current	ICC	V _{IN} = V _C	_C or GND	6.0	_	_	2.0	_	20.0	μΑ

Timing Requirements (input: $t_r = t_f = 6 \text{ ns}$)

Characteristics	Symbol	Test Condition		Ta = 25°C		Ta = _40 ~85°C	Unit
			V _{CC} (V)	Тур.	Limit	Limit	
Minimum pulse width	h		2.0	_	75	95	
(\overline{CK})	t _{W (L)}	—	4.5	—	15	19	ns
	t _{W (H)}		6.0	_	13	16	
Minimum pulse width			2.0	_	75	95	
(CLR)	t _{W (L)}	—	4.5	—	15	19	ns
			6.0	_	13	16	
			2.0	—	75	95	
Minimum set-up time	t _s	—	4.5	—	15	19	ns
			6.0	_	13	16	
			2.0	—	0	0	
Minimum hold time	t _h	—	4.5	—	0	0	ns
			6.0	_	0	0	
Minimum removal time			2.0	—	25	30	
(CLR)	t _{rem}	—	4.5	—	5	6	ns
(OLK)			6.0		5	5	
			2.0	—	6	5	
Clock frequency	f	—	4.5	—	31	25	MHz
			6.0	_	37	30	

AC Characteristics (C_L = 15 pF, V_{CC} = 5 V, Ta = 25°C, input: t_r = t_f = 6 ns)

Characteristics	Symbol	mbol Test Condition		Тур.	Max	Unit
Output transition time	t _{TLH} t _{THL}	_	_	4	8	ns
Propagation delay time $(\overline{CK} - Q, \overline{Q})$	t _{pLH} t _{pHL}	—	_	11	21	ns
Propagation delay time $(\overline{\text{CLR}} - \text{Q}, \overline{\text{Q}})$	t _{pLH} t _{pHL}	—	_	12	24	ns
Maximum clock frequency	f _{max}	_	34	75	_	MHz

AC Characteristics ($C_L = 50 \text{ pF}$, input: $t_r = t_f = 6 \text{ ns}$)

	Test Condition		-	Ta = 25°C)	Ta = -4	Linit	
Symbol		V _{CC} (V)	Min	Тур.	Max	Min	Max	Unit
t		2.0	_	30	75		95	
	—	4.5	—	8	15		19	ns
ЧНL		6.0	—	7	13		16	
+		2.0	_	48	125	_	155	
-	—	4.5	—	14	25		31	ns
чрНL		6.0	—	12	21		26	
•		2.0		52	140		175	
-	_	4.5	—	15	28	—	35	ns
tpHL		6.0	—	13	24	_	30	
		2.0	6	23		5		
f _{max}	—	4.5	31	70	—	25	—	MHz
		6.0	37	80	—	30	—	
C _{IN}				5	10		10	pF
C _{PD}	_		_	33	_	_	_	pF
	C _{IN}	Symbol tTLH — tTHL — tpLH — tpLH — tpLH — tpHL — tpHL — fmax — CIN — CPD —	Symbol Vcc (V) tTLH tTHL 2.0 tTLH tTHL 4.5 6.0 2.0 tpLH tpLH - 4.5 tpLH tpHL - 4.5 tpLH tpHL - 4.5 tpLH tpHL - 4.5 tpLH tpHL - 4.5 tpHL - - tpHL - -	Symbol Vcc (V) Min tTLH tTHL 2.0 tTHL 4.5 tpLH tpLH 4.5 tpLH tpHL 4.5 31 fmax 4.5 31 G.0 37 CPD	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Symbol V_{CC} (V) Min Typ. Max t_{TLH} 2.0 30 75 t_{THL} 4.5 8 15 t_{THL} 4.5 8 15 t_{THL} 4.5 48 125 t_{pLH} 4.5 14 25 t_{pHL} 4.5 14 25 t_{pHL} 4.5 14 25 t_{pHL} 4.5 14 25 t_{pHL} 4.5 15 28 t_{pHL} 4.5 31 70 f_{max} 4.5 31 70 f_{max} 5 10 5 10 C_{IN} 53 <td< td=""><td>Symbol V_{CC} (V) Min Typ. Max Min t_{TLH} </td><td>Symbol V_{CC} Min Typ. Max Min Max T_{LH} </td></td<>	Symbol V_{CC} (V) Min Typ. Max Min t_{TLH}	Symbol V_{CC} Min Typ. Max Min Max T_{LH}

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

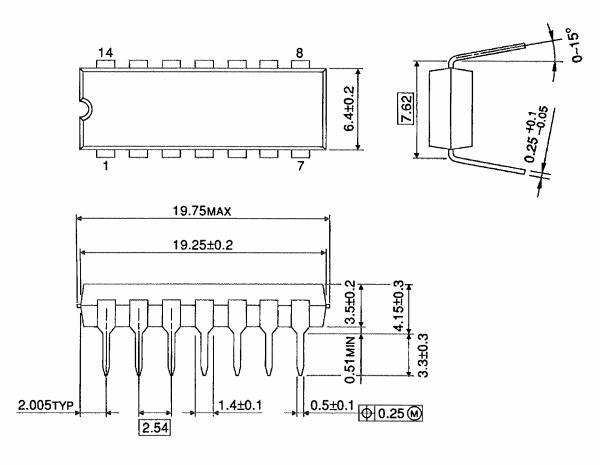
Average operating current can be obtained by the equation:

 $I_{CC} \text{ (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 \text{ (per F/F)}$

Package Dimensions

DIP14-P-300-2.54

Unit : mm



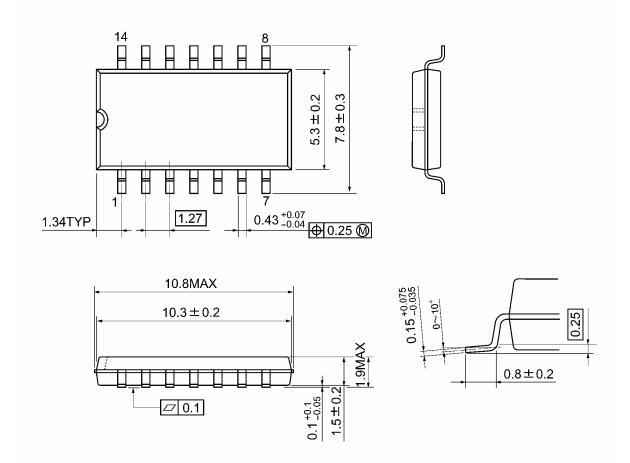
Weight: 0.96 g (typ.)



Package Dimensions

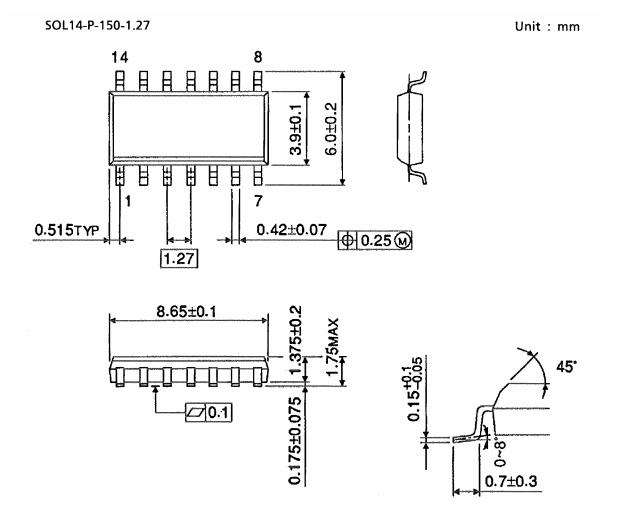
SOP14-P-300-1.27A

Unit: mm



Weight: 0.18 g (typ.)

Package Dimensions (Note)



Note: This package is not available in Japan.

Weight: 0.12 g (typ.)

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20070701-EN GENERAL

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